### REMARKS

## I. <u>Introduction</u>

In response to the pending Office Action, Applicants have amended claim 1 in order to further clarify the subject matter of the present invention. Support for claim 1 can be found, for example, in Fig. 1F through 1H and the related portions of the specification.

For the reasons set forth below, Applicants respectfully submit that all pending claims are patentable over the cited prior art.

# II. The Rejection Of Claims 1-5 And 12-13 Under 35 U.S.C. § 102

Claims 1-5 and 13 were rejected under 35 U.S.C. § 102(e) as being anticipated by Lee (Published U.S. No. 2003/0189215) and claims 1-5 and 12-13 were rejected under 35 U.S.C. § 102(e) as being anticipated by Yoo (Published U.S. No. 2004/0245543). Applicants respectfully submit that Lee and Yoo both fail to anticipate the pending claims for at least the following reasons.

With regard to the present invention, claim 1 recites, a method for fabricating semiconductor devices, the method comprising the steps of: forming a semiconductor layer containing a positive layer on a mother substrate; forming a metal layer on the semiconductor layer; separating the mother substrate from the semiconductor layer after forming the metal layer, thereby exposing a surface of the semiconductor layer; and removing a desired region of the metal layer from the direction of the exposed surface of the semiconductor layer to form a plurality of mutually separated semiconductor devices each containing the semiconductor layer.

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In contrast to the present invention, Lee performs device isolation through the etching from the metal support layer 156 side opposite to the n-GaN buffer layer 124 surface side that is exposed after the sapphire substrate 122 has separated from the buffer layer 124 (see, Figs. 14-15 of Lee). As described in paragraph [0049] of Lee, the "dicing is beneficially accomplished using photolithographic techniques to etch through the metal support layer 156 to the bottom of the passivation layer 162 (at the bottom of the trenches 130) and by removal of the passivation layer 162". Thus, Lee fails to disclose the step of removing a desired region of the metal layer from the direction of the exposed surface of the semiconductor layer to form a plurality of mutually separated semiconductor devices each containing the semiconductor layer.

By using the method of Lee, the layer serving as an underlying layer of the metal support layer 156 cannot be seen during the time of patterning. Hence, the mask alignment is rendered more difficult and the yield decreases. In contrast, the present invention provides a superior effect by removing a desired region of the metal layer from the direction of the exposed surface of the semiconductor layer from which the mother substrate has been separated.

Turning to Yoo, as the filing date of the instant application is May 21, 2004, Yoo, which has a filing date of June 3, 2004, does not constitute valid prior art. Furthermore, it is noted that the instant application claims priority to JP 2003-144480, which has a filing date of May 22, 2003, which also precedes the filing date of the provisional application to which Yoo claims priority. In view of the foregoing, it is respectfully submitted that the rejections based on the Yoo reference must be withdrawn.

As anticipation under 35 U.S.C. § 102 requires that each element of the claim in issue be found, either expressly described or under principles of inherency, in a single prior art reference,

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Kalman v. Kimberly-Clark Corp., 713 F.2d 760, 218 USPQ 781 (Fed. Cir. 1983), and at a minimum, Lee does not disclose a method for fabricating semiconductor devices by removing a desired region of the metal layer from the direction of the exposed surface of the semiconductor layer to form a plurality of mutually separated semiconductor devices each containing the semiconductor layer, it is clear that Lee does not anticipate claim 1 of the present invention.

# III. All Dependent Claims Are Allowable Because The Independent Claim From Which They Depend Is Allowable

Under Federal Circuit guidelines, a dependent claim is nonobvious if the independent claim upon which it depends is allowable because all the limitations of the independent claim are contained in the dependent claims, *Hartness International Inc. v. Simplimatic Engineering Co.*, 819 F.2d at 1100, 1108 (Fed. Cir. 1987). Accordingly, as claim 1 is patentable for the reasons set forth above, it is respectfully submitted that all pending dependent claims are also in condition for allowance.

#### IV. Conclusion

Having fully responded to all matters raised in the Office Action, Applicants submit that all claims are in condition for allowance, an indication of which is respectfully solicited.

To the extent necessary, a petition for an extension of time under 37 C.F.R. 1.136 is hereby made. Please charge any shortage in fees due in connection with the filing of this paper,

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including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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